IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Alex R. Freeman

Docket No.:

Patent5 LA.doc

Serial No.:

Examiner:

TBD

Filed:

August 23, 2001

Art Unit:

TBD

For:

C 250, 450 NOVEL MIRCO ARRAY FOR HIGH THROUGHOUT SCREENING

INFORMATION DISCLOSURE STATEMENT

Director of the U.S. Patent and Trademark Office

Appen ashington, D.C. 20231 **Box: Patent Application**

Dear Sir:

Applicant encloses the attached PTO-1449 form citing references to be considered and cited in the examination for above-identified patent application filed herewith. A copy of the references is enclosed for the convenience of the Examiner.

Applicant believes no fee is due. However, the Director is authorized to charge any fees or credit any overpayments to Deposit Account 13-4900.

Respectfully submitted,

Alex R. Freeman

Date: September 18, 2001

CYTOPLEX BIOSCIENCES, INC.

1601 Dorchester, Suite 110

Plano, Texas 75075 Telephone: (972) Facsimile: (972)

Certificate of Mailing

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to: Director of the U.S. Patent and Trademark Office, Washington, DC 20231, Box/Patent Application on the date shown below.

Date

In Place of Form PTO-1449					ARK OFFI	CE				OCKET NO.	SERIAL NO.						
									Patent!	5_LA.doc		TBD					
INFOR	RMATI	(ON)	DISC	CLOS	URE	STA	TEM	IENT	APPLICA	APPLICANT							
		(Use se	veral st	neets if	necessar	y)				Alex Freeman							
/	OIF	E							FILING D			GROUP					
			છે.					* : 0		August 23, 2001 TBD							
8	OCT O	2001	95		_			U.S. I	PATENT DO	TENT DOCUMENTS FILING							
*EXAMPLE R INITIA					N 17 13	(DED			DATE	214265	G	On C	DATE	IF			
INITIA	BADE	ABX			NUM				DATE	NAME	CLASS	SUBCLASIO	SUBCLASS APPRO- PRIATE				
	AA	4	8	5	5	2	4	0	August, 1989	Rosenstei n et al.	'	J. So. "	秋				
	AB	5	3 5 4 6 9 2		October	Yang et		0	1								
	1.0		_	<u> </u>	ļ		 -	<u> </u>	, 1994	al.		9	\bot				
	AC	5	5	2	9	7	5	6	June, 1996	Brennan et al.							
	AD	5	8	8	2	9	3	0	March,	Baier			+				
					<u> </u>		ļ	<u> </u>	1999								
	AE	5	9	1	6	4	2	8	June, 1999	Kane et al.							
	AF	5	9	8	0	7	0	4	Novembe				+				
								_	r, 1999								
							FO	REIG	N PATENT C	OCUMENTS							
											TRANS	TRANSLATIO					
		DO	DOCUMENT NUMBER						DATE	DATE COUNTRY		SUBCLASS	N				
											CLASS		YES	NO			
	AG			4			ili							155			
	AH				+												
	AI		-		-	+											
	AJ	-	11-			7		1000					1800	102			
	AJ																
			C	THE	R PR	IOR .	ART	(Inclu	ding Author,	Title, Date, Pertiner	nt Pages, E	tc.).		-			
	AK																
			+						-								
į																	
EXAMI	NFR	DAT	FCC	IIZIM	ERE	<u>n</u>				***************************************							
EXAMINER DATE CONSIDERED																	
*EXAMI		٠.	. In	itial i	f refer	ence	consi	dered,	whether or no	t citation is in conf	ormance v	rith MPEP 609; I	Draw li	ne			
through c	itation	ıt not	ın co	onforr	nance	and r	ot co	nsidei	red. Include co	opy of this form wi	th next cor	nmunication to ap	pplicati	on.			

In Place of U Form PTO-1449					RK OFFI	CE				OCKET NO. 5 LA.doc	SERVAL NO.	7				
INFOR	MATI	ON I)ISC	ו חכו	HDF	STAT	ГЕМ	ENT		ATTY. DOCKET NO. Patent5_LA.doc APPLICANT Alex Freeman						
INFOR		(tise ser	veral sh	eets if n	ecessar	y)	1 12141	LIVI	Alex Freeman							
		F							FILING D		GROUP O					
	007 n		8					11 C D		August 23, 2001 TBD ATENT DOCUMENTS						
E		2007	8					U.S. P	ALENI DO	CUMENTS						
*EXAMINE R INITIAL	OEMA	BIDOS	CUM	ENT	NUM	1BER			DATE	NAME	CLAS	SUBCLASS	FILING DATE I APPRO- PRIATE	F		
	AA	5	5 9 8 6 6 7 9				9	Novembe r, 1999	et al.							
	AB	6	0	6	3	2	6	0	May, 2000	Olesen et al.						
	AC	6 0 9 0 2 5 1		1	July, 2000	Sundberg et al.										
	AD	6	0	9	3	2	9	6	July, 2000	Soane et al.						
	AE	6	1	0	3	1	9	9	August, 200	et al.						
	AF	6	1	0	3	5	3	7	August, 2000	Ullman et al.						
FOREIGN PATENT DOCUMENTS																
		D	101 11	MFN'	r NII	МВЕ	R		DATE COUNTRY		CLAS	S SUBCLASS	TRANSI N	TRANSLATIO N		
				VILI V	1 110	.,,,,,,,	•						YES	NO		
	AG	<u> </u>														
	AH															
	AI															
I	AJ		Ì													
			(THE	R PR	IOR	ART	(Inclu	ding Author,	Title, Date, Pertine	nt Pages,	Etc.).				
	1	1	T													
	AK		-			<u></u>			- w							
		<u> </u>														
EXAM	INER	DAT	E C	JNSI	DERI	E D										
*EXAM through		ifno								not citation is in con copy of this form w						

In Place of Form PTO-144			MERCE RADEMA	ARK OFF	CE			ATTY. DOCKET NO. Patent5 LA.doc				SERIAL VO. TBD				
INFO	RMAT	QN I	DISC	LOS	URE	STA	TEM	ENT	APPLICANT							
	OIA	(Kare	veral sh	eets if r	recessar	y)			Alex Freeman							
6	îr.	٩	5						FILING DATE				CAROUP S			
BATEMI S	U II 1	2001	8) —					IIS P		August 23, 2001 TBD TENT DOCUMENTS						
	,		<i>y</i>					0.5.1			THE TOTAL PROPERTY OF THE PROP		0			
*EXAM NE R INITIAL	R VSAL A OV										NAME	CLASS	SUBCLASS	FILING DATE IF APPRO- PRIATE		
	AA							6	, - '		Shalon et al.					
	AB	6	1	5	6	1	7	8	December , 2000		Mansfiel d et al.					
	AC	6	1	7	6	9	6	2	January 2001	January, Soane et 2001 al.						
	AD															
	AE															
	AF															
	FOREIGN PATENT DOCUMENTS															
TRANSLATIO													TATIO			
		Do	OCUI	MENT	ΓNU	MBE	R		DATE COUNTRY		CLASS	CLASS SUBCLASS		N		
· · · · · · · · · · · · · · · · · · ·	1.0	<u> </u>							<u> </u>	ļ				TES	NO	
	AG	_														
	AH															
	AI	:														
	AJ															
			0	THE	R PR	IOR .	ART	(Includ	ling Author	, Tit	le, Date, Pertiner	nt Pages,	Etc.).	1		
	AK		_				·									
EXAMI	NFR	DAT	F CC	NSII)FDE	D					·					
22 27 21411	ı ILIX	JAI		11 4 D I F	LKE	U										
*EXAMI through o		if not	In:	itial if	refernance	ence and r	consideration co	dered, nsidere	whether or red. Include	not c	citation is in conf y of this form wit	ormance th next co	with MPEP 609; I	Draw lu plication	ne on.	
										-						